

TOSHIBA HIGH EFFICIENCY DIODE STACK (HED) SILICON EPITAXIAL TYPE

U20JL2C48A

SWITCHING TYPE POWER SUPPLY APPLICATION

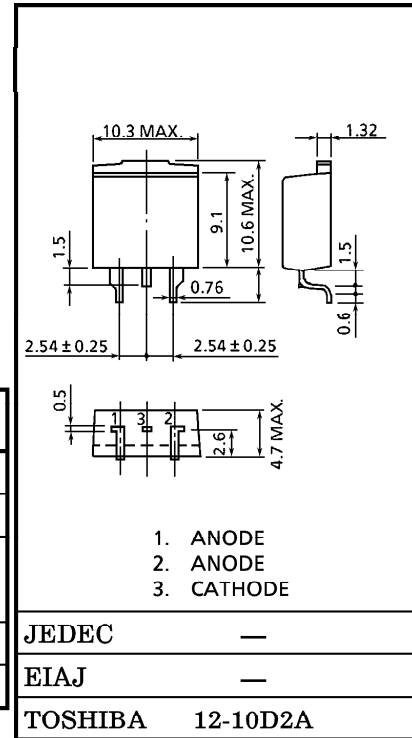
Unit in mm

CONVERTER & CHOPPER APPLICATION

- Repetitive Peak Reverse Voltage : $V_{RRM}=600V$
- Average Output Rectified Current : $I_O=20A$
- Ultra Fast Reverse-Recovery Time : $t_{rr}=35ns$ (Max.)
- Low Switching Losses and Output Noise.

MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Reverse Voltage	V_{RRM}	600	V
Average Output Rectified Current	I_O	20	A
Peak One Cycle Surge Forward Current (Sin Wave)	I_{FSM}	80 (50Hz) 88 (60Hz)	A
Junction Temperature	T_j	-40~150	°C
Storage Temperature Range	T_{stg}	-40~150	°C



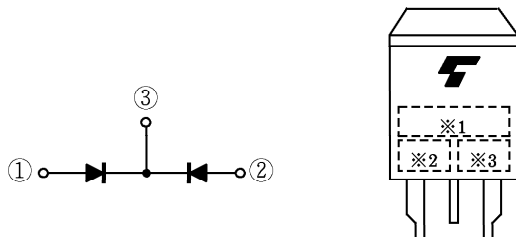
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	MAX.	UNIT
Peak Forward Voltage	V_{FM}	$I_{FM}=10A$	—	3.2	V
Repetitive Peak Reverse Current	I_{RRM}	$V_{RRM}=600V$	—	50	μA
Reverse Recovery Time	t_{rr}	$I_F=2A, di/dt=-50A/\mu s$	—	35	ns
Forward Recovery Time	t_{fr}	$I_F=1A$	—	100	ns
Thermal Resistance	$R_{th(j-c)}$	DC Total, Junction to Case	—	1.6	°C/W

Note 1 : $V_{FM}, I_{RRM}, t_{rr}, t_{fr}$... A value of one cell.

Polarity

Marking



※1	MARK	20JL2C
※2	A	
※3	Lot Number	
	□□-Month (Starting from Alphabet A)	
	Year (Last Number of the Christian Era)	

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